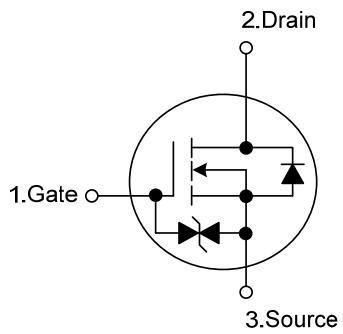


F75NM65Z**Power MOSFET****75A, 650V N-CHANNEL
SUPER-JUNCTION MOSFET****■ DESCRIPTION**

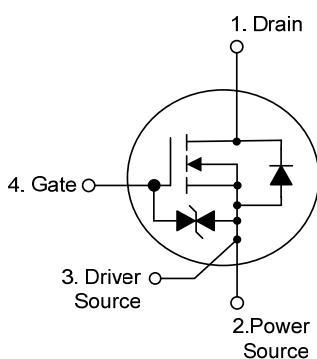
The **UTC F75NM65Z** is an N-channel enhancement mode silicon-gate power MOSFET with fast body diode and ESD Type, designed for high-voltage, high-speed power switching applications. such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics.

■ FEATURES

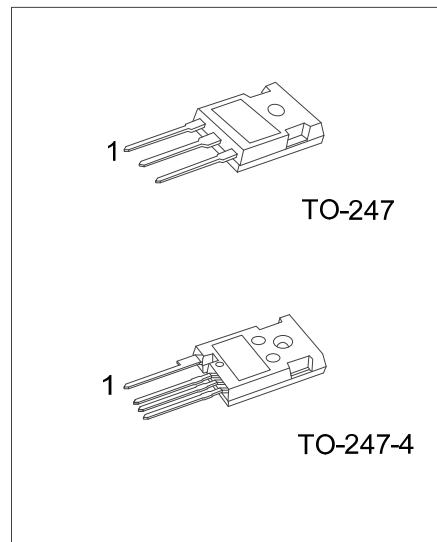
- * $R_{DS(ON)} \leq 46 \text{ m}\Omega$ @ $V_{GS}=10\text{V}$, $I_D=35\text{A}$
- * Fast body diode MOSFET technology
- * Low switching losses due to reduced Q_{rr}
- * Single Pulse Avalanche Energy Rated
- * Fast Switching Speeds
- * Linear Transfer Characteristics
- * High Input Impedance
- * Avalanche energy tested

■ SYMBOL

TO-247



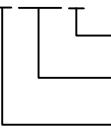
TO-247-4



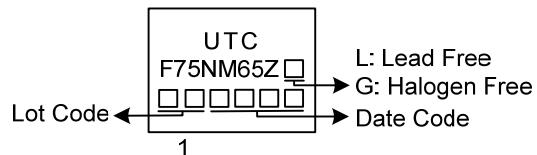
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment				Packing
Lead Free	Halogen Free		1	2	3	4	
F75NM65ZL-T47-T	F75NM65ZG-T47-T	TO-247	G	D	S	-	Tube
F75NM65ZL-T474-T	F75NM65ZG-T474-T	TO-247-4	D	S	S	G	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

F75NM65ZG-T47-T 	(1) T: Tube (2) T47: TO-247, T474: TO-247-4 (3) G: Halogen Free and Lead Free, L: Lead Free
------------------------------------------------------------------------------------------------------	---------------------------------------------------------------------------------------------------

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	± 30	V
Drain Current	Continuous	I_D	75	A
	Pulsed (Note 2)	I_{DM}	150	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	1150	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	12.7	V/nS
Power Dissipation		P_D	400	W
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L = 100\text{mH}$, $I_{AS} = 4.8\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD} \leq 30\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	40	$^\circ\text{C/W}$
Junction to Case	θ_{JC}	0.3	$^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise specified)

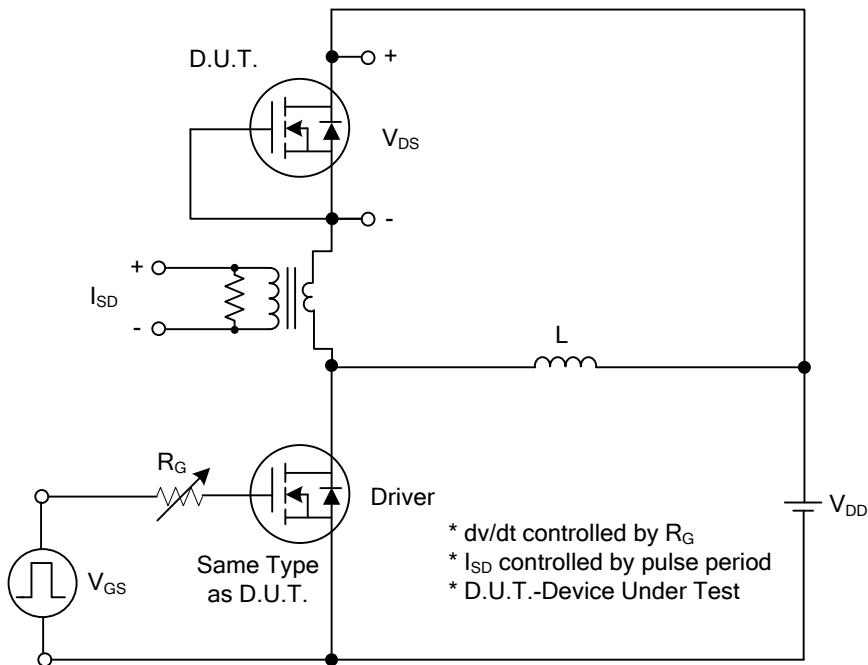
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	650			V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=650\text{V}$, $V_{GS}=0\text{V}$			10	μA
Gate- Source Leakage Current	Forward	$V_{GS}=+30\text{V}$, $V_{DS}=0\text{V}$			+10	μA
	Reverse	$V_{GS}=-30\text{V}$, $V_{DS}=0\text{V}$			-10	μA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	2.5		4.5	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10\text{V}$, $I_D=35\text{A}$			46	$\text{m}\Omega$
DYNAMIC PARAMETERS						
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, $f=1.0\text{MHz}$		6710		pF
Output Capacitance	C_{oss}			467		pF
Reverse Transfer Capacitance	C_{rss}			1		pF
SWITCHING PARAMETERS						
Total Gate Charge (Note 1)	Q_G	$V_{DS}=520\text{V}$, $V_{GS}=10\text{V}$, $I_D=75\text{A}$ (Note1, 2)		160		nC
Gate to Source Charge	Q_{GS}			35		nC
Gate to Drain Charge	Q_{GD}			58		nC
Turn-ON Delay Time (Note 1)	$t_{D(ON)}$	$V_{DS}=100\text{V}$, $V_{GS}=10\text{V}$, $I_D=75\text{A}$, $R_G=25\Omega$ (Note1, 2)		80		ns
Rise Time	t_R			50		ns
Turn-OFF Delay Time	$t_{D(OFF)}$			450		ns
Fall-Time	t_F			24		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Body-Diode Continuous Current	I_S				75	A
Maximum Body-Diode Pulsed Current	I_{SM}				150	A
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	$I_S=75\text{A}$, $V_{GS}=0\text{V}$			1.4	V
Body Diode Reverse Recovery Time (Note 1)	t_{rr}	$I_S=30\text{A}$, $V_{GS}=0\text{V}$, $dI/dt=100\text{A}/\mu\text{s}$		205		ns
Body Diode Reverse Recovery Charge	Q_{rr}			1.4		μC

Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

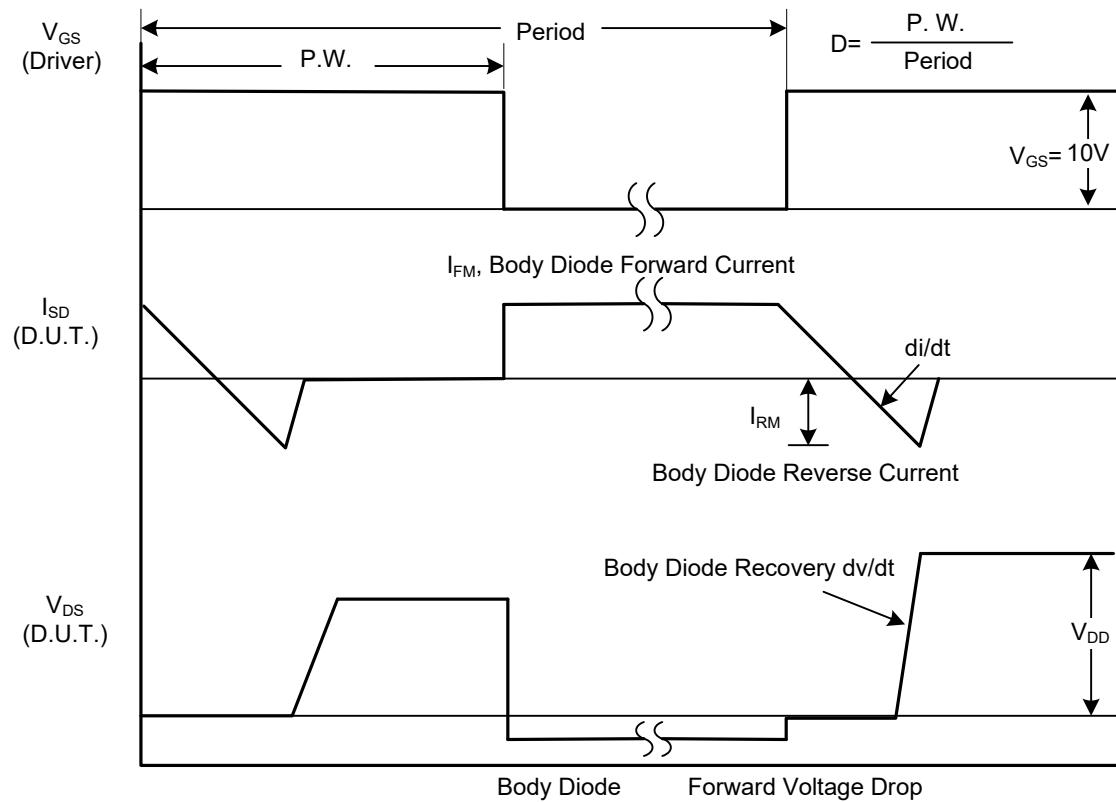
2. Essentially independent of operating ambient temperature.



■ TEST CIRCUITS AND WAVEFORMS

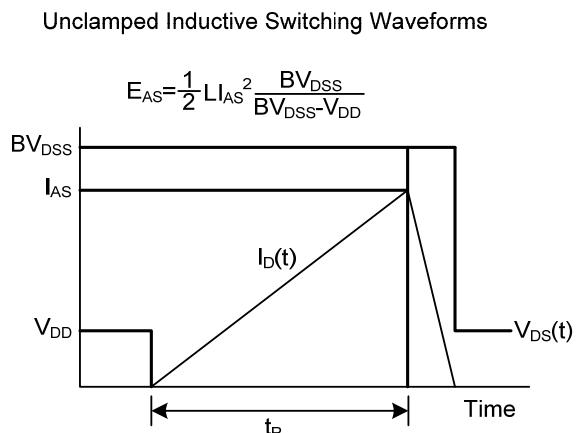
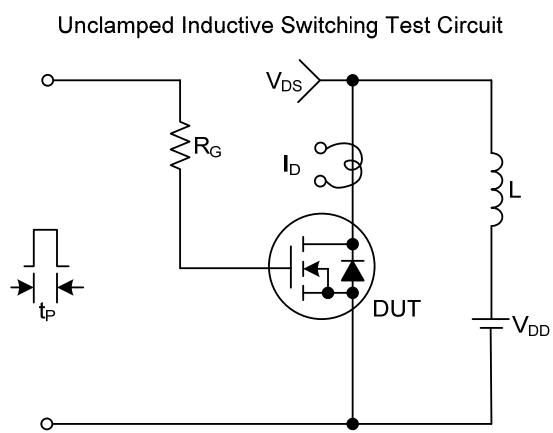
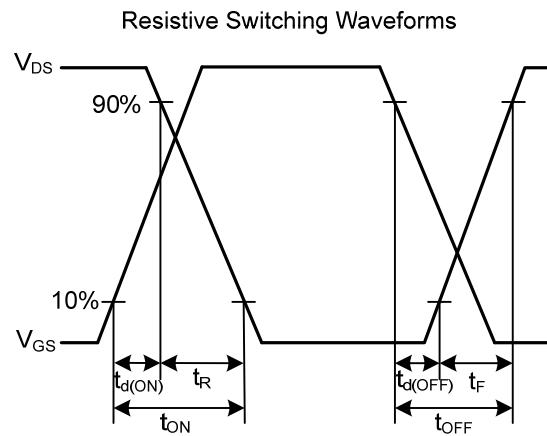
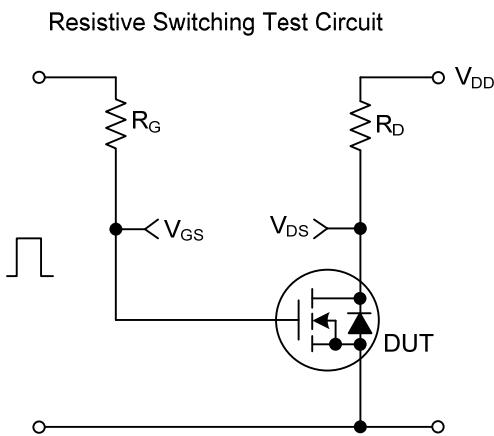
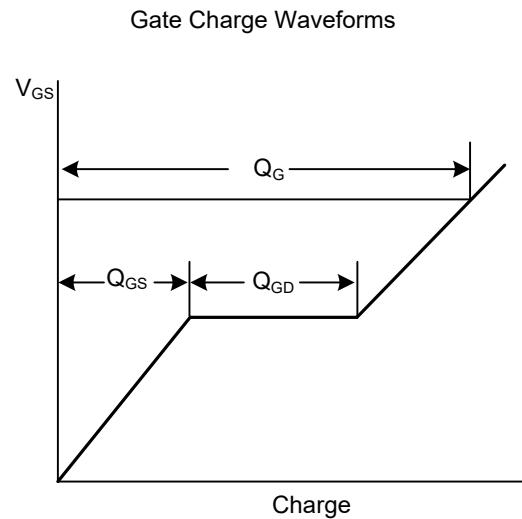
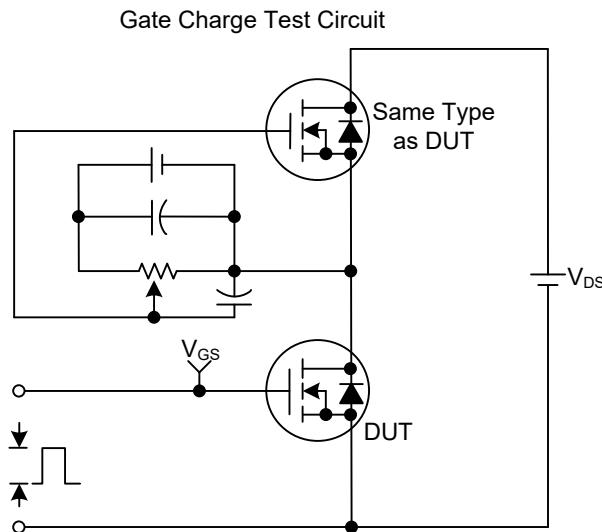


Peak Diode Recovery dv/dt Test Circuit

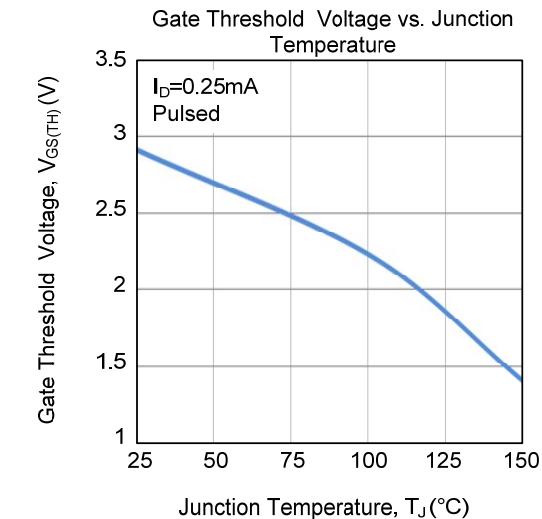
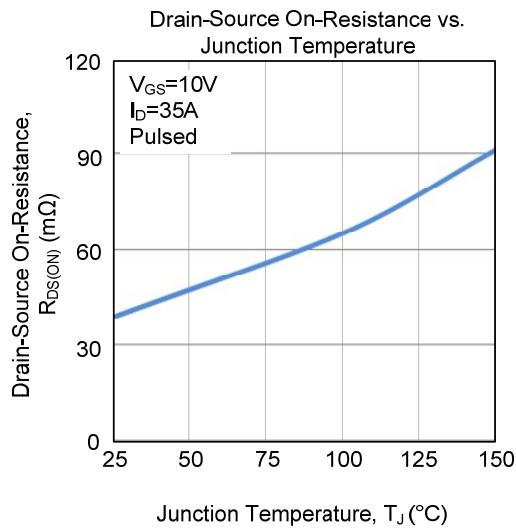
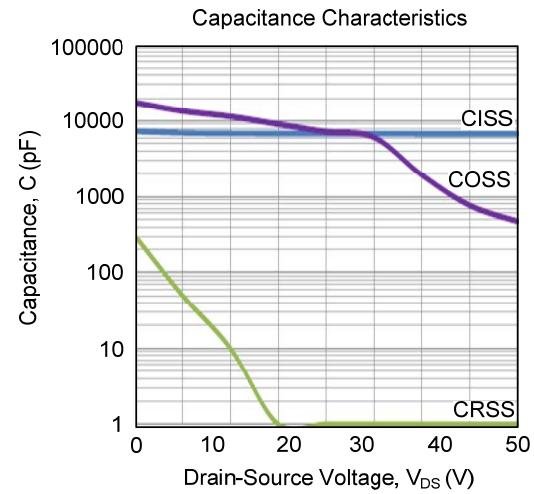
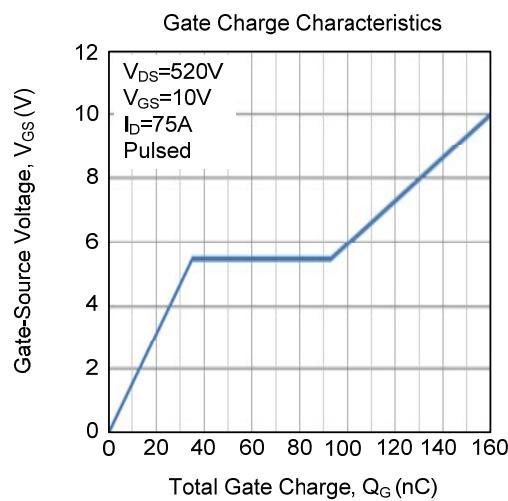
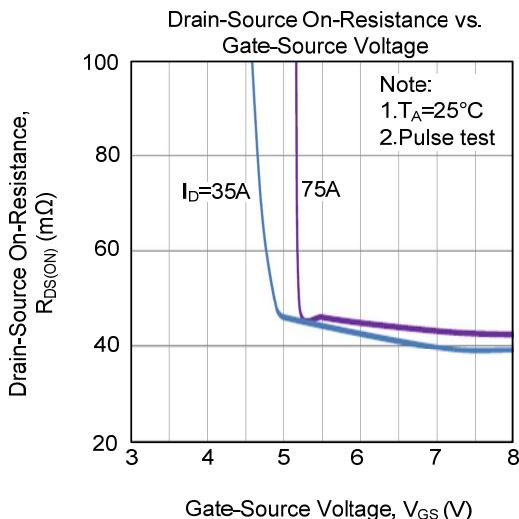
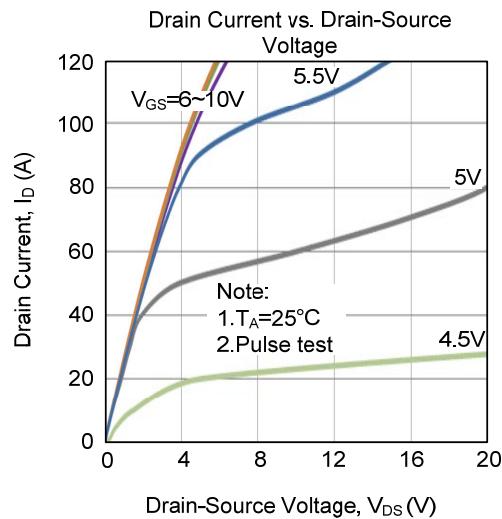


Peak Diode Recovery dv/dt Waveforms

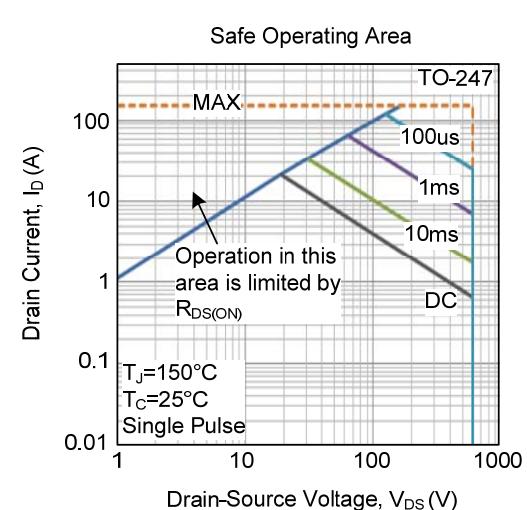
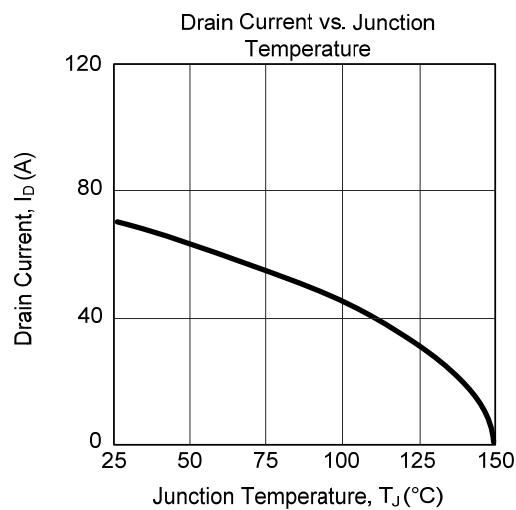
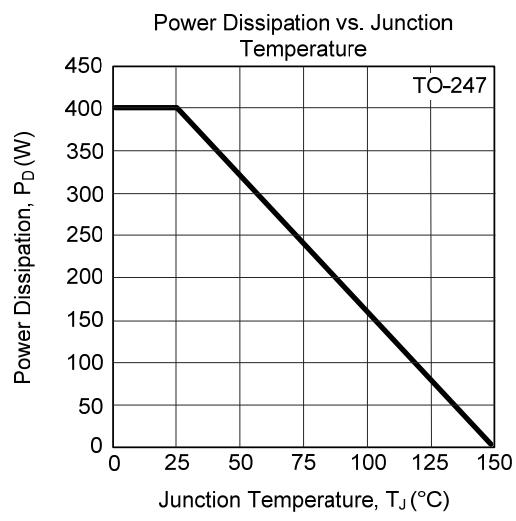
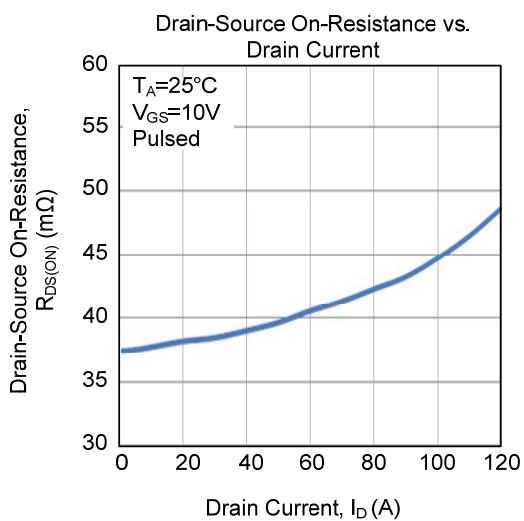
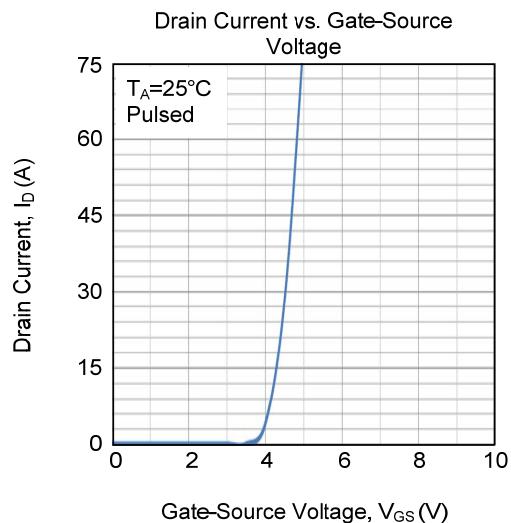
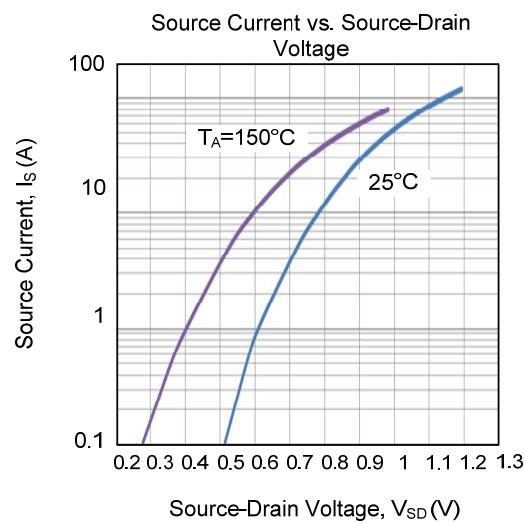
■ TEST CIRCUITS AND WAVEFORMS



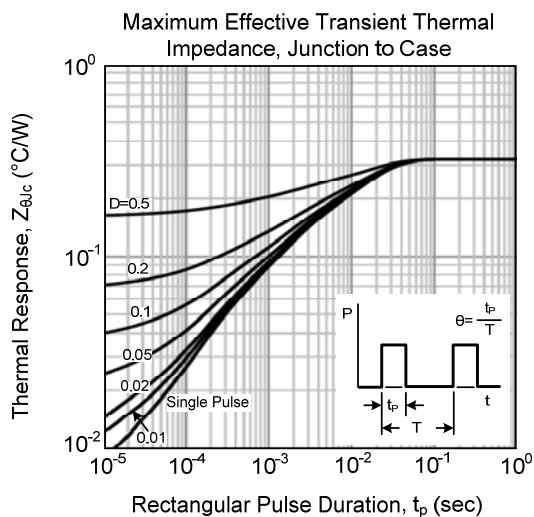
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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